

<b>Notice of References Cited</b>	Application/Control No. 10/813,809	Applicant(s)/Patent Under Reexamination HUTCHISON ET AL.	
	Examiner Nhan T. Le	Art Unit 2618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,106,857	09-2006	Hyotylainen, Janne	379/433.04
*	B	US-7,019,985	03-2006	Lefort, Loi	361/814
*	C	US-6,320,963	11-2001	Whitney, George R.	379/447
*	D	US-2002/0039890	04-2002	Kim, Jai Chul	455/90
*	E	US-2003/0211834	11-2003	Wu et al.	455/90.3
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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